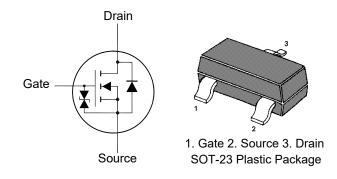
#### **N-Channel Enhancement Mode MOSFET**

#### **Features**

- · Advanced trench cell design
- Built-in G-S Protection Diode
- Typical ESD Protection HBM Class 2

Classification	Voltage Range(V)				
0A	< 125				
0B	125 to < 250				
1A	250 to < 500				
1B	500 to < 1000				
1C	1000 to < 2000				
2	2000 to < 4000				
3A	4000 to < 8000				
3B	≥ 8000				



## **Applications**

- · Portable appliances
- Battery management

#### Absolute Maximum Ratings(at Ta = 25°C unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>G</sub> S	± 20	V
Drain Current	ID	3	Α
Peak Drain Current, Pulsed 1)	I <sub>DM</sub>	12	Α
Power Dissipation	P <sub>tot</sub>	1 <sup>2)</sup> 0.54 <sup>3)</sup>	W
Operating Junction Temperature	Tj	150	°C
Storage Temperature Range	T <sub>stg</sub>	- 55 to + 150	°C

#### **Thermal Characteristics**

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Ambient	Reja	125 <sup>2)</sup> 231 <sup>3)</sup>	°C/W

<sup>&</sup>lt;sup>1)</sup> Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.



 $<sup>^{2)}</sup>$  Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate, t  $\leq$  10 s.

<sup>&</sup>lt;sup>3)</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad.

# MMFTN0360K

## Characteristics at T<sub>a</sub> = 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS					
Drain-Source Breakdown Voltage at I <sub>D</sub> = 250 μA	BV <sub>DSS</sub>	60	-	-	V
Drain-Source Leakage Current at V <sub>DS</sub> = 60 V	IDSS	-	-	1	μΑ
Gate Leakage Current at V <sub>GS</sub> = ± 20 V	Igss	-	-	± 10	μΑ
Gate-Source Threshold Voltage at $V_{DS}$ = 10 V, $I_D$ = 250 $\mu A$	V <sub>GS(th)</sub>	1	-	2.5	V
Drain-Source On-State Resistance at $V_{GS}$ = 10 V, $I_D$ = 3 A at $V_{GS}$ = 4.5 V, $I_D$ = 3 A at $V_{GS}$ = 4 V, $I_D$ = 3 A	R <sub>DS(on)</sub>	- - -	- - -	85 100 105	mΩ
DYNAMIC PARAMETERS	ı		T	T	
Forward Transconductance at $V_{DS} = 5 \text{ V}$ , $I_D = 2 \text{ A}$	<b>g</b> FS	-	4.3	-	S
Gate Resistance at $V_{DS} = 0 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$	Rg	-	1.37	-	Ω
Input Capacitance at $V_{DS}$ = 30 V, $V_{GS}$ = 0 V, f = 1 MHz	Ciss	-	446	-	pF
Output Capacitance at $V_{DS}$ = 30 V, $V_{GS}$ = 0 V, f = 1 MHz	Coss	-	22	-	pF
Reverse Transfer Capacitance at $V_{DS}$ = 30 V, $V_{GS}$ = 0 V, f = 1 MHz	Crss	-	18	-	pF
Gate Charge Total at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A at $V_{DS}$ = 30 V, $V_{GS}$ = 4.5 V, $I_D$ = 2 A	Qg	1 1	8.6 4	- -	nC
Gate to Source Charge at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A	Q <sub>gs</sub>	-	1.8	-	nC
Gate to Drain Charge at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A	$Q_{gd}$	-	1.2	-	nC
Turn-On Delay Time at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A, $R_g$ = 4.7 $\Omega$	t <sub>d(on)</sub>	-	7	-	ns
Turn-On Rise Time at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A, $R_g$ = 4.7 $\Omega$	tr	-	2	-	ns
Turn-Off Delay Time at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A, $R_g$ = 4.7 $\Omega$	t <sub>d(off)</sub>	-	6	-	ns
Turn-Off Fall Time at $V_{DS}$ = 30 V, $V_{GS}$ = 10 V, $I_D$ = 2 A, $R_g$ = 4.7 $\Omega$	t <sub>f</sub>	-	5	-	ns
Body-Diode PARAMETERS					
Diode Forward Voltage at $I_S = 1 A$ , $V_{GS} = 0 V$	V <sub>SD</sub>	-	-	1.2	V
Body-Diode Continuous Current	Is	-	-	3	Α
Body Diode Reverse Recovery Time at $I_S = 2$ A, di/dt = 100 A / $\mu$ s	t <sub>rr</sub>	-	8	-	ns
Body Diode Reverse Recovery Charge at $I_S = 2$ A, di/dt = 100 A / $\mu$ s	Qrr	-	4	-	nC



#### **Electrical Characteristics Curves**

Fig. 1 Typical Output Characteristics

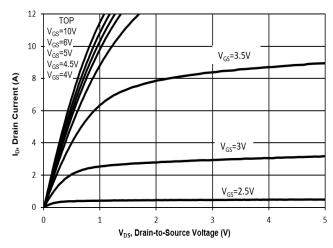


Fig. 2 Typical Transfer Characteristics

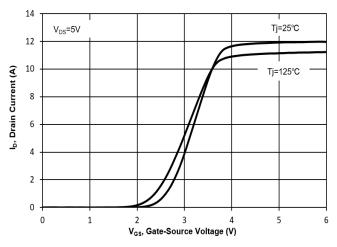


Fig. 3 On-Resistance vs. Drain Current

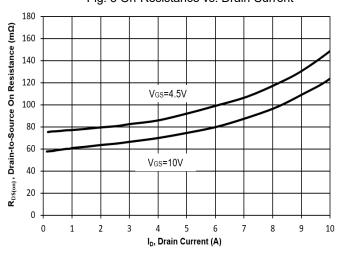


Fig. 4 On-Resistance vs. Gate-Source Voltage

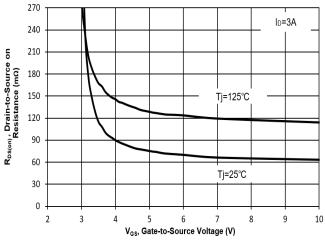


Fig. 5 On-Resistance vs.T<sub>i</sub>

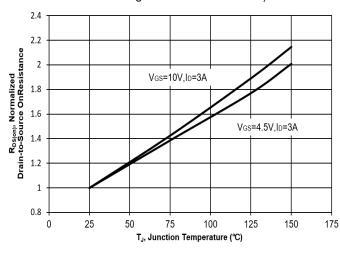
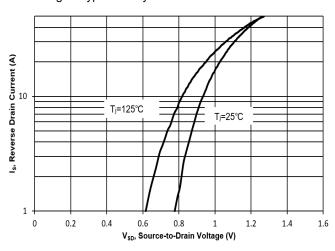


Fig. 6 Typical Body-Diode Forward Characteristics





#### **Electrical Characteristics Curves**

Fig. 7 Typical Junction Capacitance

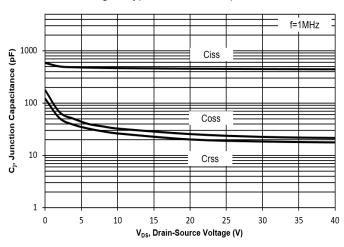


Fig. 8 Drain-Source Leakage Current vs. Tj

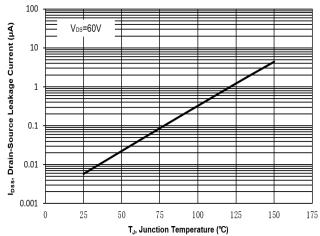


Fig. 9  $V_{(BR)DSS}$  vs. Junction Temperature

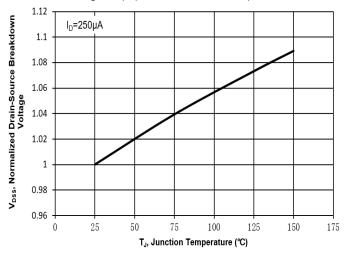


Fig. 10 Gate Threshold Variation vs. T<sub>j</sub>

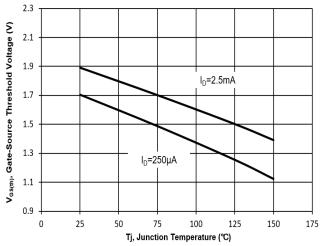
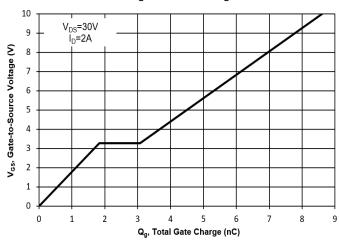


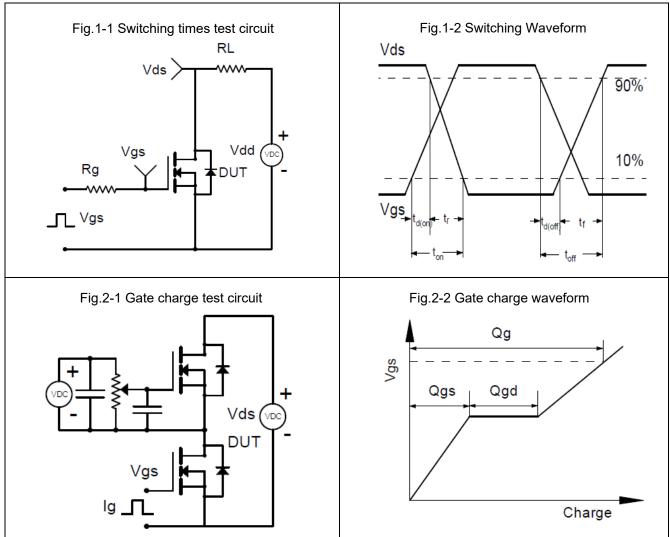
Fig. 11 Gate Charge





## MMFTN0360K

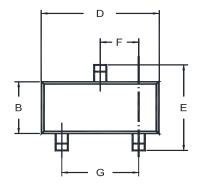
### **Test Circuits**

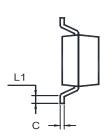


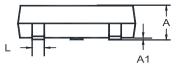


## Package Outline (Dimensions in mm)

**SOT-23** 

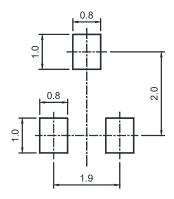






Unit	Α	A1	В	С	D	E	F	G	L	L1
mm	1.20	0.100	1.40	0.19	3.04	2.6	1.02	2.04	0.51	0.2
mm	0.89	0.013	1.20	0.08	2.80	2.2	0.89	1.78	0.37	MIN

### **Recommended Soldering Footprint**



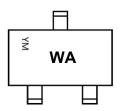
**Packing information** 

Package	Tape Width	Pitch		Reel	Size		
	(mm)	mm	inch	mm	inch	Per Reel Packing Quantity	
SOT-23	8	4 ± 0.1	0.157 ± 0.004	178	7	3,000	

### **Marking information**

- " WA " = Part No.
- " YM " = Date Code Marking
- " Y " = Year
- " M " = Month

Font type: Arial



Disclaimer: Our company reserve the right to make modifications, enhancements, improvements, corrections or other changes to improve product design, functions and reliability, anytime without notice. Semtech Electronics Limited makes no warranties, representations or warranties regarding the suitability of its products for any particular purpose, and does not accept any liability arising from the application or use of any product or circuit such as: Apply to medical, military, aircraft, space or life support equipment and expressly waive any and all liability, including but not limited to special, consequential or collateral damage.

